



Product Service

RF - TEST REPORT

Report Number : **68.850.10.102.01** Date of Issue: 26 January 2011

Model : **NI3421-A01**

Product Type : Tablet PC

Applicant : Notion Ink Design Labs Pvt. Ltd.

Address : 6th Block, D tower, Subramanya Arcade, Bannerghatta Road,
Bangalore, Karnataka, India 560029

Production Facility : Wanlida Group Co., Ltd.

Address : Wanlida Industry Zone, Nanjing, Fujian, China 363601

Test Result : ☒ **Positive** ☐ **Negative**

Total pages including
Appendices : 51

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2 Details about the Test Laboratory

Details about the Test Laboratory

Test site1:

Company name: Jiangsu TÜV Product Service Ltd. – Shenzhen Branch
6th Floor, H Hall,
Century Craftwork Culture Square,
No. 4001, Fuqiang Road,
Futian District 518048,
Shenzhen,P.R.C.

Telephone: 86 755 8828 6998

Fax: 86 755 8828 5299

Test site2:

Company name: Audix Technology (shenzhen) Co.,Ltd
Block Shenzhen, Science & Industry Park,
Nantou, Shenzhen,
Guangdong,
China

Telephone: 86 755 2663 9496

Fax: 86 755 2663 2877



3 Description of the Equipment Under Test

Description of the Equipment Under Test

Product: Tablet PC

Model no.: NI3421-A01

Options and accessories: NIL

Rating: DC 19V, 2.1A
Test with adaptor:
Input: AC 100-240V, 50/60Hz, 1A
Output: DC 19V, 2.1A

RF Transmission
Frequency: 2402-2480MHz

Description of the EUT: NIL

Auxiliary Equipment Used during Test:

DESCRIPTION	MANUFACTURER	MODEL NO.(SHIELD)	S/N(LENGTH)
Laptop	Lenovo	X61	L3-L3729 08/03



Product Service

4 Summary of Test Standards

Test Standards	
Part 15 Subpart C, Oct. 1, 2009	PART 15 - RADIO FREQUENCY DEVICES Subpart C - Intentional Radiators

5 Summary of Test Results

Technical Requirements					
FCC Part 15 Subpart C					
Test Condition	Pages	Test Result			Test Location
		Pass	Fail	N/A	
15.207 Conducted Emission AC Power Port	8	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	Test Site2
15.247 (b) (1) Conducted peak output power	12	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	Test Site2
15.247(d) Band edge compliance of RF emissions	14	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	Test Site2
15.247(d) Spurious RF conducted emissions	20	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	Test Site2
15.247(d) 15.209 Spurious radiated emissions	25	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	Test Site2
15.247(a)(1) 20dB bandwidth	29	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	Test Site2
15.247(a)(1) Carrier frequency separation	35	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	Test Site2
15.247(a)(1)(iii) Number of hopping frequencies	39	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	Test Site2
15.247(a)(1)(iii) Dwell Time	43	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	Test Site2

6 General Remarks

Remarks

This submittal(s) (test report) is intended for FCC ID: Y2GNI3421A01 comply with Section 15.207, 15.209, 15.247 of the FCC Part 15, Subpart C Rules.

SUMMARY:

All tests according to the regulations cited on page 5 were

☒ - Performed

☐ - **Not** Performed

The Equipment Under Test

☒ - **Fulfills** the general approval requirements.




☐ - **Does not** fulfill the general approval requirements.

Sample Received Date: 5 December 2010

Testing Start Date: 6 December 2010

Testing End Date: 29 December 2010

- Jiangsu TÜV Product Service Ltd. – Shenzhen Branch -

Tested By	<u>2011-01-26</u>	<u>Sunny Lu</u>	
Test Lab Engineer	Date	Name	Signature
Prepared By	<u>2011-01-26</u>	<u>Ken Li</u>	
Project Engineer	Date	Name	Signature
Reviewed By	<u>2011-01-26</u>	<u>Paul Yu</u>	
Assistant EMC Manager	Date	Name	Signature

7 Technical Requirement

7.1 Conducted Emission

Test Method

- 1 The EUT was placed on a table, which is 0.8m above ground plane
- 2 The power line of the EUT is connected to the AC mains through a Artificial Mains Network (A.M.N.).
- 3 Maximum procedure was performed to ensure EUT compliance
- 4 A EMI test receiver is used to test the emissions from both sides of AC line

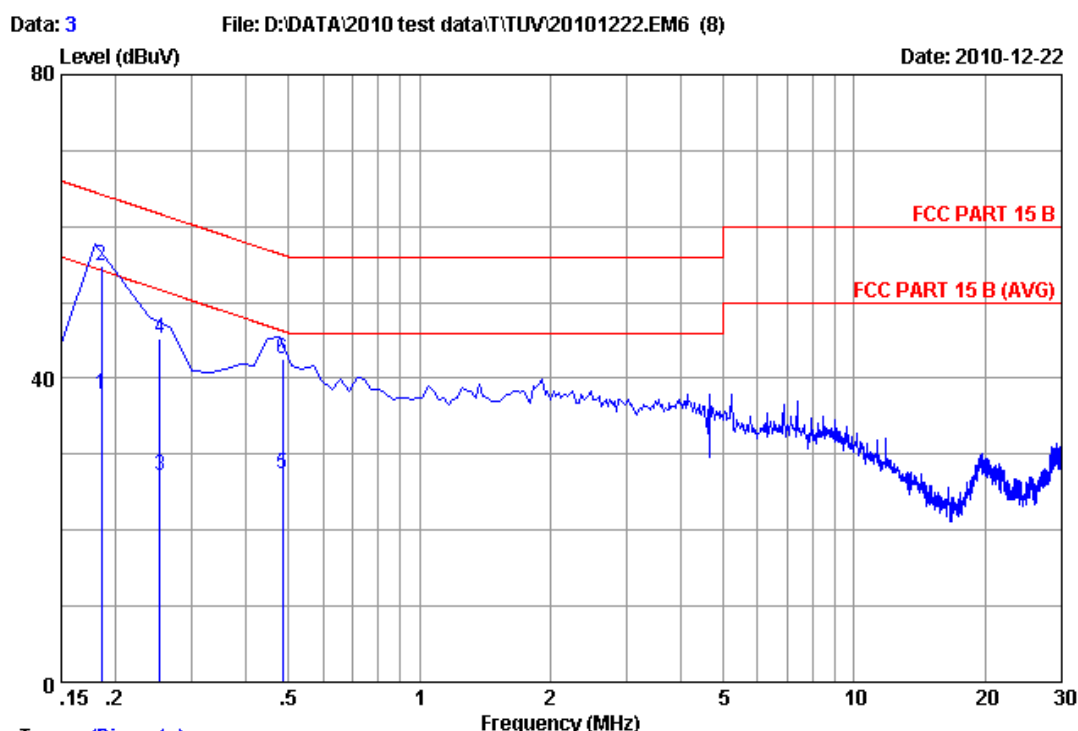
Limit

Frequency MHz	QP Limit dB μ V	AV Limit dB μ V
0.150-0.500	66-56*	56-46*
0.500-5	56	46
5-30	60	50

Decreasing linearly with logarithm of the frequency

Remark: This test was carried out in all the test modes, here only the worst test result was shown.

Conducted Emission



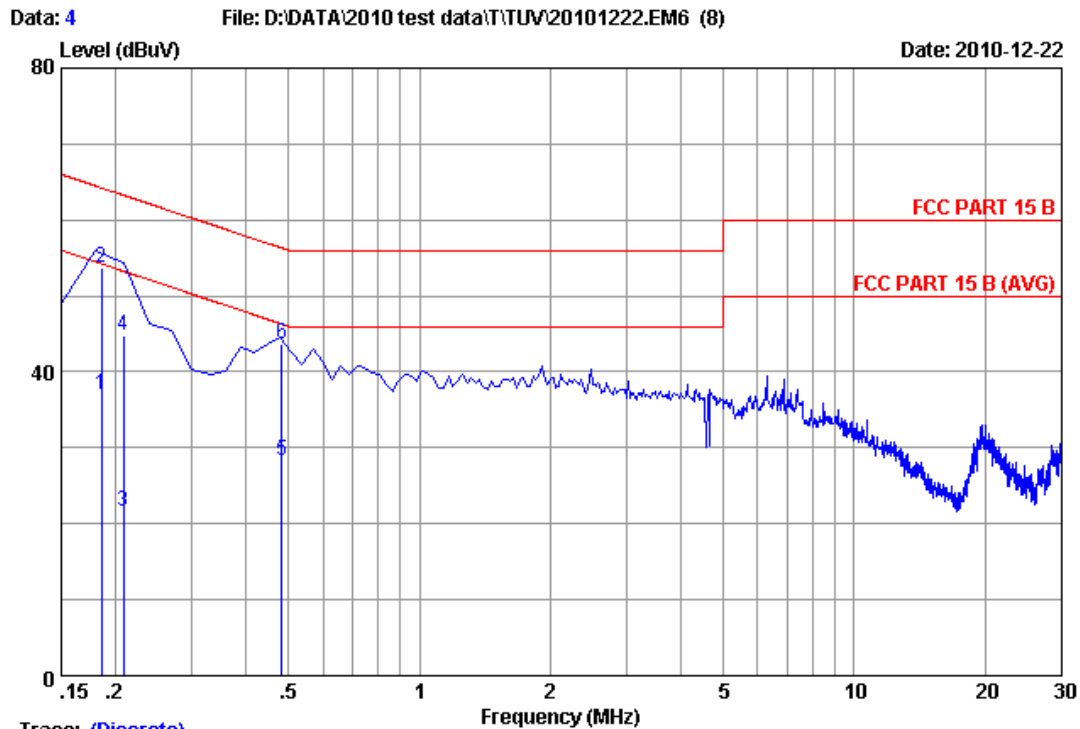
Trace: (Discrete)

Site no :1#conduction Data No :3
 Dis./Ant. :** 2011 ESH2-Z5 LINE
 Limit :FCC PART 15 B
 Env./Ins. :29.5°C/55% Engineer :Restar
 EUT :NI3421-A01
 Power Rating :DC 19V Adapter Input 120V/60Hz
 Test Mode :Bluetooth

No	Freq (MHz)	LISN Factor (dB)	Cable Loss (dB)	Reading (dBuV)	Emission Level (dBuV)	Limits (dBuV)	Margin (dB)	Remark
1	0.18600	0.17	9.88	27.80	37.85	54.21	16.36	Average
2	0.18600	0.17	9.88	44.80	54.85	64.21	9.36	QP
3	0.25300	0.17	9.88	17.10	27.15	51.66	24.51	Average
4	0.25300	0.17	9.88	35.20	45.25	61.66	16.41	QP
5	0.48400	0.19	9.88	17.40	27.47	46.27	18.80	Average
6	0.48400	0.19	9.88	32.50	42.57	56.27	13.70	QP

Remarks: 1.Emission Level=LISN Factor+Cable Loss(Include 10dB pulse limit)
 +Reading.
 2.If the average limit is met when using a quasi-peak detector.
 the EUT shall be deemed to meet both limits and measurement
 with average detector is unnecessary.

Conducted Emission



Trace: (Discrete)

Site no :1#conduction Data No :4
 Dis./Ant. :** 2011 ESH2-Z5 NEUTRAL
 Limit :FCC PART 15 B
 Env./Ins. :29.5°C/55% Engineer :Restar
 EUT :NI3421-A01
 Power Rating :DC 19V Adapter Input 120V/60Hz
 Test Mode :Bluetooth

No	Freq (MHz)	LISN Factor (dB)	Cable Loss (dB)	Reading (dBuV)	Emission Level (dBuV)	Limits (dBuV)	Margin (dB)	Remark
1	0.18600	0.21	9.88	26.80	36.89	54.21	17.32	Average
2	0.18600	0.21	9.88	43.60	53.69	64.21	10.52	QP
3	0.20900	0.21	9.88	11.50	21.59	53.24	31.65	Average
4	0.20900	0.21	9.88	34.80	44.89	63.24	18.35	QP
5	0.48300	0.22	9.88	18.30	28.40	46.29	17.89	Average
6	0.48300	0.22	9.88	33.50	43.60	56.29	12.69	QP

Remarks: 1.Emission Level=LISN Factor+Cable Loss(Include 10dB pulse limit)
 +Reading.

2.If the average limit is met when using a quasi-peak detector.
 the EUT shall be deemed to meet both limits and measurement
 with average detector is unnecessary.

Test Equipment List

DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.	CAL. DUE DATE
Test Receiver	Rohde & Schwarz	ESHS10	838693/001	Dec.18, 10
L.I.S.N.#1	Rohde & Schwarz	ESH2-Z5	834066/011	Mar.30, 11
L.I.S.N.#3	Kyoritsu	KNW-242C	8-1920-1	May.08, 11
Terminator	Hubersuhner	50Ω	No. 1	May.08, 11
Terminator	Hubersuhner	50Ω	No. 2	May.08, 11
RF Cable	Fujikura	3D-2W	LISN Cable 1#	May.08, 11
Coaxial Switch	Anritsu	MP59B	M55367	May.08, 11
Passive Probe	Rohde & Schwarz	ESH2-Z3	299.7810.52	May.08, 11
Pulse Limiter	Rohde & Schwarz	ESH3-Z2	100341	May.08, 11

7.2 Conducted peak output power

Test Method

The transmitter output is connected to the Spectrum analyzer. The Spectrum analyzer is set to the peak power detection.

Limits for conducted peak output power measurements

Frequency Range MHz	Limit W	Limit dBm
------------------------	------------	--------------

Conducted peak output power

Bluetooth Mode GFSK modulation Test Result

Frequency MHz	Conducted Peak Output Power dBm	Result
CH3 2402MHz	-0.90	Pass
CH6 2441MHz	0.52	Pass
CH9 2480MHz	0.91	Pass

Bluetooth Mode 8DPSK modulation Test Result

Frequency MHz	Conducted Peak Output Power dBm	Result
CH3 2402MHz	1.65	Pass
CH6 2441MHz	2.97	Pass
CH9 2480MHz	3.35	Pass



Product Service

Test Equipment

DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.	CAL DUE DATE
Spectrum Analyzer	Agilent	E4446A	US44300459	May 08, 2011

7.3 Band edge compliance of RF emissions

Test Method

The band edge compliance of RF radiated emission should be measured by following the guidance in ANSI C63.4 with respect to maximizing the emission by rotating the EUT, measuring the emission while the EUT is situated in three orthogonal planes (if appropriate), adjusting the measurement antenna height and polarization etc. Set RBW and VBW to 1MHz to measure the peak field strength and set RBW to 1MHz and VBW to 10Hz to measure the average radiated field strength.

The conducted RF band edge was measured by using a spectrum analyzer. Set span wide enough to capture the highest in-band emission and the emission at the band edge. Set RBW and VBW to 100kHz, to measure the conducted peak band edge.

Limits

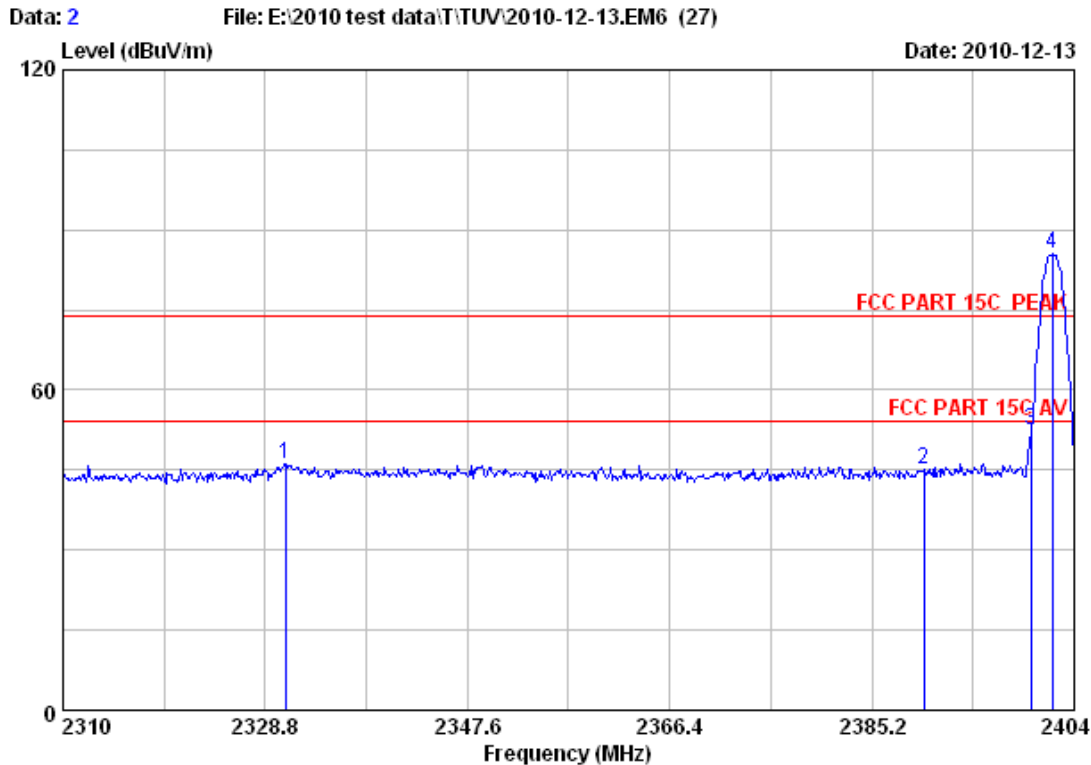
According to §15.247(d), in any 100 kHz bandwidth outside the frequency bands in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in 15.209(a) (see Section 15.205(c)).

Frequency MHz	Limit Average dBuV/m	Limit Peak dBuV/m
Below 2390 Above 2483.5	54	74

Band edge compliance of RF emissions

Bluetooth Mode GFSK Modulation Test Result:

Lower edge peak Plot:



Site no. : RF Chamber Data no. : 2
 Dis. / Ant. : 3m 3115(0911) Ant. pol. : VERTICAL
 Limit : FCC PART 15C PEAK
 Env. / Ins. : 23°C/54% Engineer : Sunny-lu
 EUT : NI3421-A01
 Power : DC 19V From Adapter input AC 120V/60Hz
 Test mode : GFSK 2402MHz Tx
 M/N :

	Ant.	Cable	Amp.		Emission				
Freq.	Factor	loss	Factor	Reading	Level	Limits	Margin	Remark	
(MHz)	(dB/m)	(dB)	(dB)	(dBuV)	(dBuV/m)	(dBuV/m)	(dB)		
1 2330.680	29.40	7.27	36.63	46.02	46.06	74.00	27.94	Peak	
2 2390.000	29.44	7.39	36.62	44.81	45.02	74.00	28.98	Peak	
3 2400.000	29.44	7.43	36.62	52.11	52.36	74.00	21.64	Peak	
4 2401.932	29.44	7.43	36.62	85.29	85.54	74.00	-11.54	Peak	

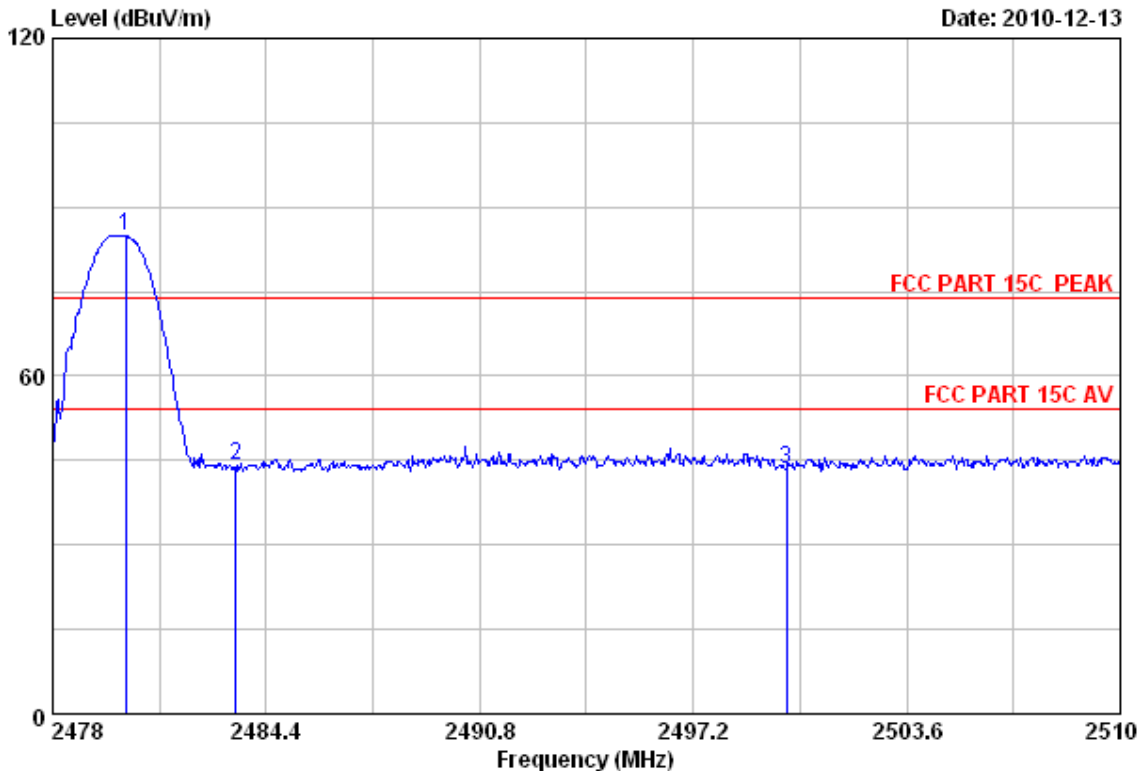
Remarks:

1. Emission Level= Antenna Factor + Cable Loss -Amp Factor + Reading.
2. The emission levels that are 20dB below the official limit are not reported.

Upper edge peak Plot:

Data: 5 File: E:\2010 test data\TUV\2010-12-13.EM6 (27)

Date: 2010-12-13



Site no. : RF Chamber Data no. : 5
Dis. / Ant. : 3m 3115(0911) Ant. pol. : VERTICAL
Limit : FCC PART 15C PEAK
Env. / Ins. : 23°C/54% Engineer : Sunny-lu
EUT : NI3421-A01
Power : DC 19V From Adapter input AC 120V/60Hz
Test mode : GFSK 2480MHz Tx
M/N :

	Ant.	Cable	Amp.		Emission				
Freq.	Factor	loss	Factor	Reading	Level	Limits	Margin	Remark	
(MHz)	(dB/m)	(dB)	(dB)	(dBUV)	(dBUV/m)	(dBUV/m)	(dB)		
1 2480.176	29.49	7.58	36.60	84.59	85.06	74.00	-11.06	Peak	
2 2483.500	29.49	7.58	36.60	43.66	44.13	74.00	29.87	Peak	
3 2500.000	29.50	7.62	36.60	42.84	43.36	74.00	30.64	Peak	

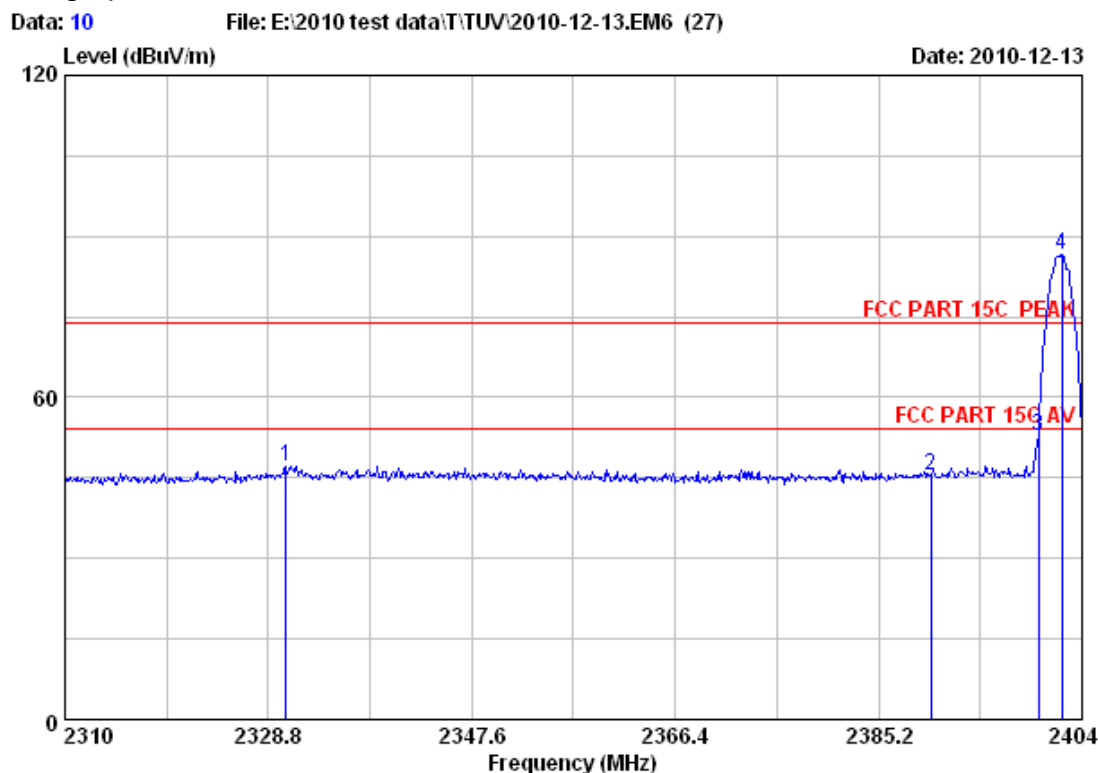
Remarks:

1. Emission Level= Antenna Factor + Cable Loss -Amp Factor + Reading.
2. The emission levels that are 20dB below the official limit are not reported.

Band edge compliance of RF emissions

Bluetooth Mode 8DPSK Modulation Test Result:

Lower edge peak Plot:



Site no. : RF Chamber Data no. : 10
 Dis. / Ant. : 3m 3115(0911) Ant. pol. : VERTICAL
 Limit : FCC PART 15C PEAK
 Env. / Ins. : 23°C/54% Engineer : Sunny-lu
 EUT : NI3421-A01
 Power : DC 19V From Adapter input AC 120V/60Hz
 Test mode : 8DPSK 2402MHz Tx
 M/N :

	Ant.	Cable	Amp.		Emission				
Freq.	Factor	loss	Factor	Reading	Level	Limits	Margin	Remark	
(MHz)	(dB/m)	(dB)	(dB)	(dBuV)	(dBuV/m)	(dBuV/m)	(dB)		
1 2330.398	29.40	7.27	36.63	47.14	47.18	74.00	26.82	Peak	
2 2390.000	29.44	7.39	36.62	45.22	45.43	74.00	28.57	Peak	
3 2400.000	29.44	7.43	36.62	52.67	52.92	74.00	21.08	Peak	
4 2402.120	29.44	7.43	36.62	86.24	86.49	74.00	-12.49	Peak	

Remarks:

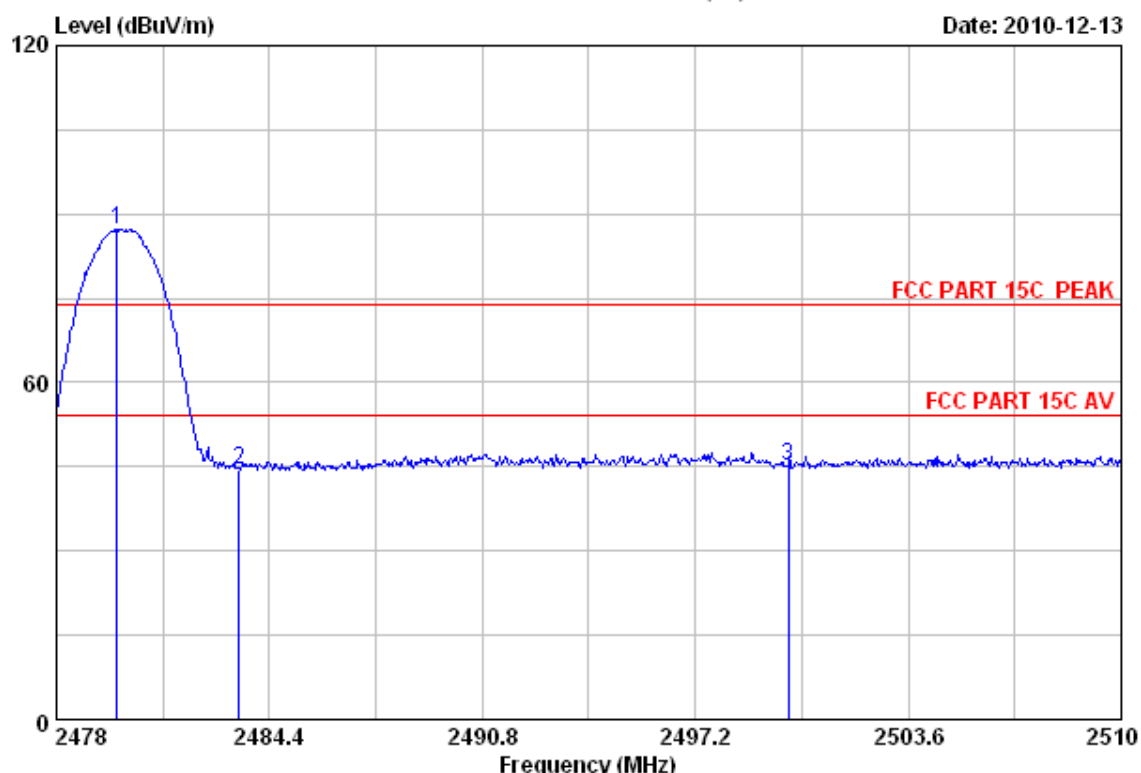
1. Emission Level= Antenna Factor + Cable Loss -Amp Factor + Reading.
2. The emission levels that are 20dB below the official limit are not reported.

Upper edge peak Plot:

Data: 6

File: E:\2010 test data\T\TUV\2010-12-13.EM6 (27)

Date: 2010-12-13



Site no. : RF Chamber Data no. : 6
Dis. / Ant. : 3m 3115(0911) Ant. pol. : VERTICAL
Limit : FCC PART 15C PEAK
Env. / Ins. : 23°C/54% Engineer : Sunny-lu
EUT : NI3421-A01
Power : DC 19V From Adapter input AC 120V/60Hz
Test mode : 8DPSK 2480MHz Tx
M/N :

	Ant.	Cable	Amp.		Emission				
Freq.	Factor	loss	Factor	Reading	Level	Limits	Margin	Remark	
(MHz)	(dB/m)	(dB)	(dB)	(dBuV)	(dBuV/m)	(dBuV/m)	(dB)		
1 2479.824	29.49	7.58	36.60	86.74	87.21	74.00	-13.21	Peak	
2 2483.500	29.49	7.58	36.60	44.12	44.59	74.00	29.41	Peak	
3 2500.000	29.50	7.62	36.60	44.58	45.10	74.00	28.90	Peak	

Remarks:

- Emission Level= Antenna Factor + Cable Loss -Amp Factor + Reading.
- The emission levels that are 20dB below the official limit are not reported.



Product Service

Test Equipment List

DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.	CAL DUE DATE
Spectrum	Agilent	E4446A	US44300459	May 08, 2011
Amp	HP	8449B	3008A02495	May 08, 2011
Antenna	EMCO	3115	9607-4877	May 17, 2011
Bilog Antenna	Schaffner	CBL6111C	2598	Dec.14, 2010
HF Cable	Hubersuhne	Sucoflex104	---	May 08, 2011

7.4 Spurious RF conducted emissions

Test Method

The transmitter output is connected to the Spectrum analyzer. The Spectrum analyzer is set to the peak power detection.

Conducted RF measurements of the transmitter output were made to confirm that the EUT antenna port conducted emissions meet the specified limit and to identify any spurious signals that require further investigation or measurements on the radiated emissions site.

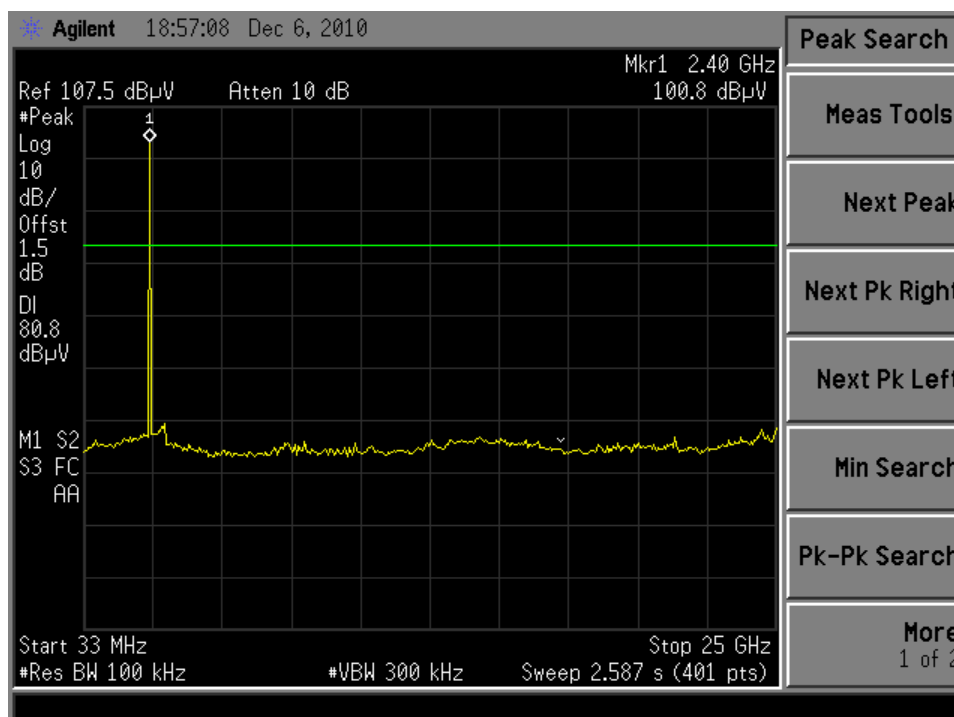
The resolution bandwidth(RBW) and the video bandwidth (VBW) of the spectrum analyzer were respectively set to 100kHz and 100kHz.

Limit

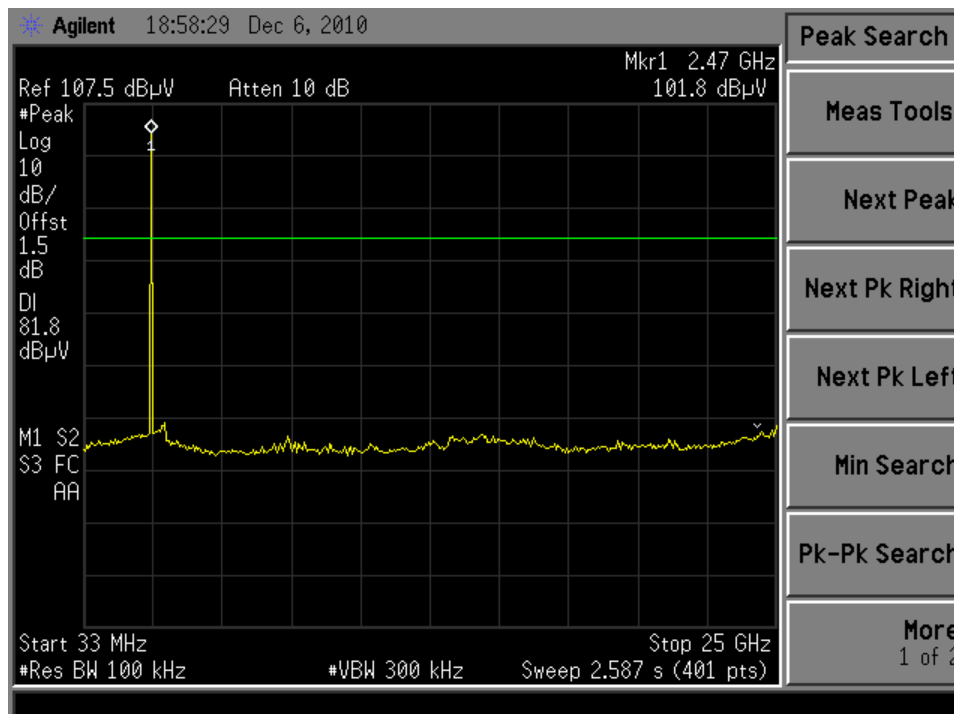
Frequency Range MHz	Limit (dBc)
1000-25000	-20

Spurious RF conducted emissions

Bluetooth Mode GFSK Modulation Test Result:
2402MHz

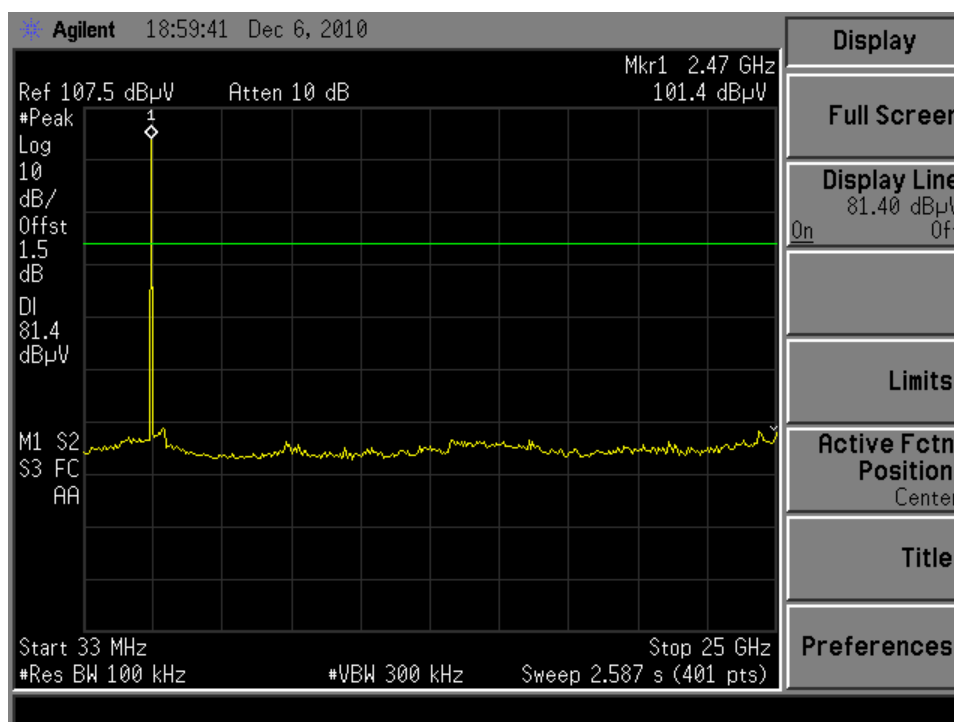


2441MHz



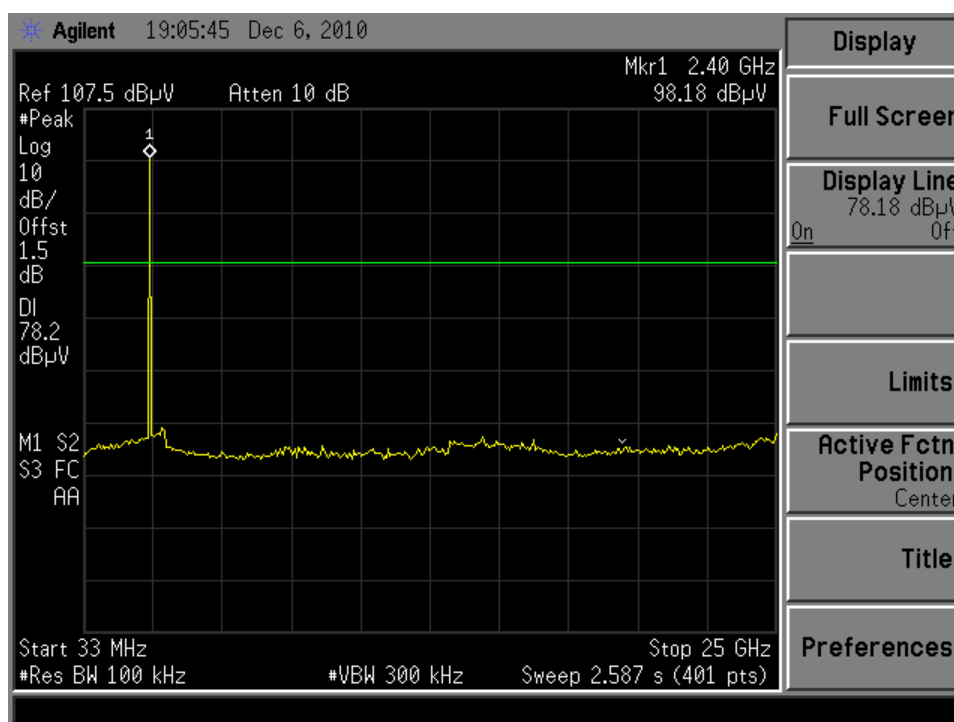
Spurious RF conducted emissions

2480MHz



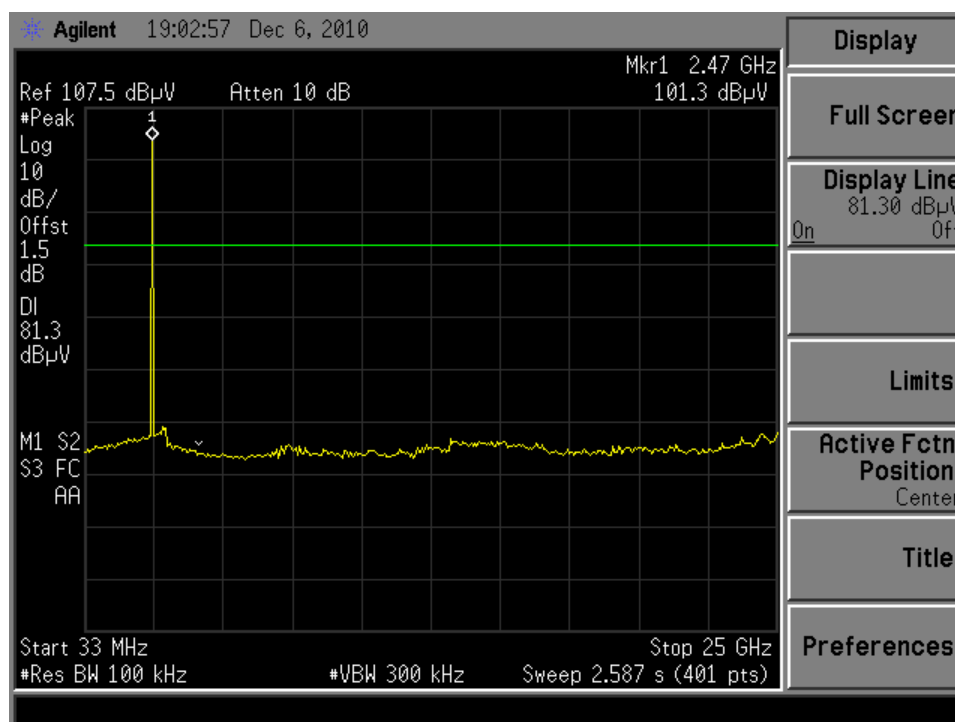
Bluetooth Mode 8DPSK Modulation Test Result:

2402MHz

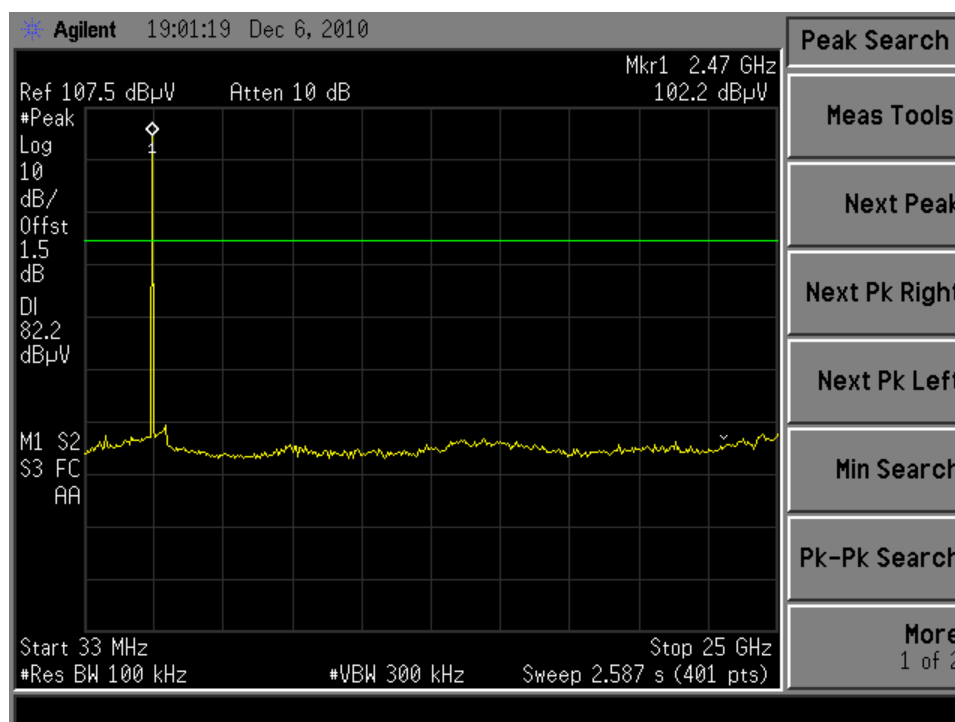


Spurious RF conducted emissions

2441MHz



2480MHz





Product Service

Test Equipment List

DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.	CAL.DUE.DATE
Spectrum Analyzer	Agilent	E74505A	MY45111421	Nov. 10, 2011

7.5 Spurious radiated emissions

Test Method

- 1 The EUT is placed on a turntable, which is 0.8m above ground plane.
- 2 The turntable shall be rotated for 360 degrees to determine the position of maximum emission level
- 3 EUT is set 3m away from the receiving antenna, which is varied from 1m to 4m to find out the highest emissions.
- 4 Maximum procedure was performed on the six highest emissions to ensure EUT compliance.
- 5 Each emission was to be maximized by changing the polarization of receiving antenna both horizontal and vertical.

Limit

Frequency MHz	Field Strength uV/m	Field Strength dBμV/m	Detector
30-88	100	40	QP
88-216	150	43.5	QP
216-960	200	46	QP
960-1000	500	54	QP
Above 1000	500	54	AV
Above 1000	5000	74	PK

Radiated Emission

Bluetooth Mode GFSK Modulation 2402MHz Test Result

Frequency	Antenna Factor	Cable Loss	Amp. Factor	Reading	Emission Level	Polarization	Limit	Detector	Result
MHz	dB/m	dB	dB	dBuV	dBuV/m		dBμV/m		
173.560	9.88	1.41	0	24.78	36.07	Horizontal	43.5	QP	Pass
371.250	15.52	2.79	0	20.80	39.11	Horizontal	46.0	QP	Pass
742.950	20.15	4.67	0	13.77	38.59	Horizontal	46.0	QP	Pass
1595.000	26.96	5.88	36.95	42.23	38.12	Horizontal	74	PK	Pass
4804.000	34.30	10.62	35.10	44.39	54.21	Horizontal	74	PK	Pass
4804.000	34.30	10.62	35.10	30.58	40.40	Horizontal	54	AV	Pass
7206.000	-	-	-	-	-	-	-	-	-
7206.000	-	-	-	-	-	-	-	-	-

Bluetooth Mode GFSK Modulation 2441MHz Test Result

Frequency	Antenna Factor	Cable Loss	Amp. Factor	Reading	Emission Level	Polarization	Limit	Detector	Result
MHz	dB/m	dB	dB	dBuV	dBuV/m		dBμV/m		
4882.000	34.41	10.71	35.03	44.51	54.60	Horizontal	74	PK	Pass
4882.000	34.41	10.71	35.03	30.58	40.67	Horizontal	54	AV	Pass
7323.000	-	-	-	-	-	-	-	-	-
7323.000	-	-	-	-	-	-	-	-	-

Bluetooth Mode GFSK Modulation 2480MHz Test Result

Frequency	Antenna Factor	Cable Loss	Amp. Factor	Reading	Emission Level	Polarization	Limit	Detector	Result
MHz	dB/m	dB	dB	dBuV	dBuV/m		dBμV/m		
4960.000	34.54	10.08	34.95	44.46	54.85	Horizontal	74	PK	Pass
4960.000	34.54	10.08	34.95	30.73	41.12	Horizontal	54	AV	Pass
7440.000	-	-	-	-	-	-	-	-	-
7440.000	-	-	-	-	-	-	-	-	-

Remark:

- (1) Emission Level= Antenna Factor +Cable Loss - Amp. factor + Reading
- (2) Data of measurement within this frequency range shown “-” in the table above means the reading of emissions are attenuated more than 20db below the permissible limits or the field strength is too small to be measured.

Radiated Emission

Bluetooth Mode 8DPSK Modulation 2402MHz Test Result

Frequency	Antenna Factor	Cable Loss	Amp. Factor	Reading	Emission Level	Polarization	Limit	Detector	Result
MHz	dB/m	dB	dB	dBuV	dBuV/m		dBμV/m		
62.010	6.54	0.86	0	20.20	27.60	Horizontal	46.0	QP	Pass
519.850	10.64	1.92	0	22.66	35.22	Horizontal	46.0	QP	Pass
4804.000	34.30	10.62	35.10	43.61	53.43	Horizontal	74	PK	Pass
4804.000	34.30	10.62	35.10	30.44	40.26	Horizontal	54	AV	Pass
7206.000	-	-	-	-	-	-	-	-	-
7206.000	-	-	-	-	-	-	-	-	-

Bluetooth Mode 8DPSK Modulation 2441MHz Test Result

Frequency	Antenna Factor	Cable Loss	Amp. Factor	Reading	Emission Level	Polarization	Limit	Detector	Result
MHz	dB/m	dB	dB	dBuV	dBuV/m		dBμV/m		
4882.000	34.41	10.71	35.03	43.85	53.94	Horizontal	74	PK	Pass
4882.000	34.41	10.71	35.03	30.59	40.68	Horizontal	54	AV	Pass
7323.000	-	-	-	-	-	-	-	-	-
7323.000	-	-	-	-	-	-	-	-	-

Bluetooth Mode 8DPSK Modulation 2480MHz Test Result

Frequency	Antenna Factor	Cable Loss	Amp. Factor	Reading	Emission Level	Polarization	Limit	Detector	Result
MHz	dB/m	dB	dB	dBuV	dBuV/m		dBμV/m		
4960.000	34.54	10.08	34.95	44.32	54.71	Horizontal	74	PK	Pass
4960.000	34.54	10.08	34.95	30.76	41.15	Horizontal	54	AV	Pass
7440.000	-	-	-	-	-	-	-	-	-
7440.000	-	-	-	-	-	-	-	-	-

Remark:

- (1) Emission Level= Antenna Factor +Cable Loss - Amp. factor + Reading
- (2) Data of measurement within this frequency range shown “-” in the table above means the reading of emissions are attenuated more than 20db below the permissible limits or the field strength is too small to be measured.



Product Service

Test Equipment List

DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.	CAL DUE DATE
Spectrum	Agilent	E4446A	US44300459	May 08, 2011
Amp	HP	8449B	3008A02495	May 08, 2011
Antenna	EMCO	3115	9607-4877	May 17, 2011
Bilog Antenna	Schaffner	CBL6111C	2598	Dec.14, 2010
HF Cable	Hubersuhne	Sucoflex104	---	May 08, 2011

7.6 20 dB bandwidth

Test Method

- 1 Place the EUT on the table and set it in the transmitting mode.
- 2 Remove the antenna from the EUT and then connect a low loss RF cable from the antenna port to the spectrum analyzer.
- 3 Mark the peak frequency and –20dB (upper and lower) frequency.

Limit

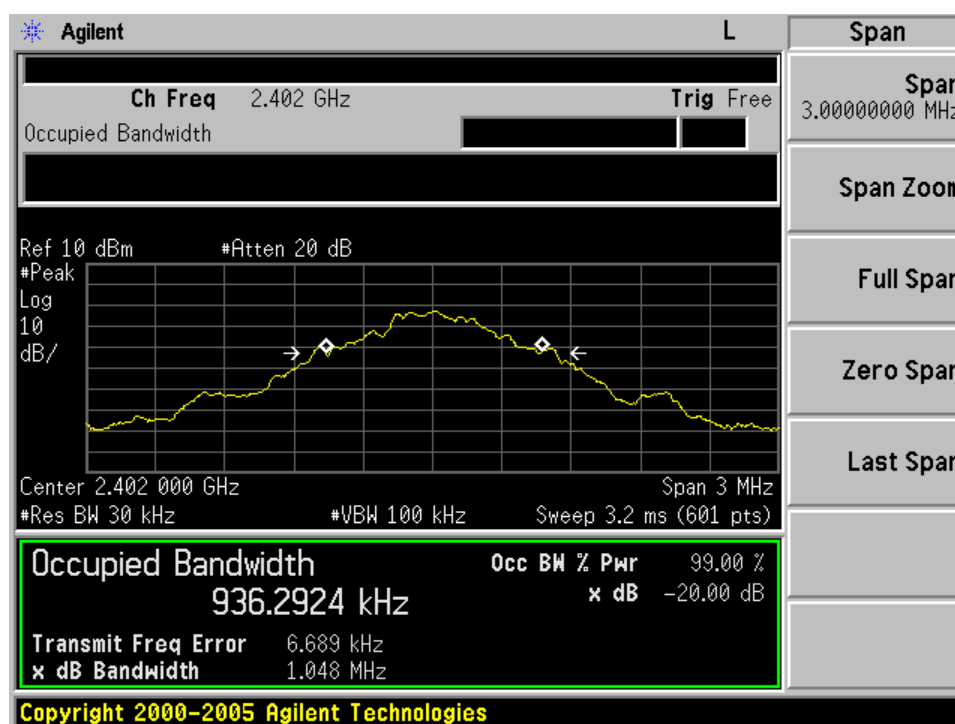
Limit [kHz]

N/A

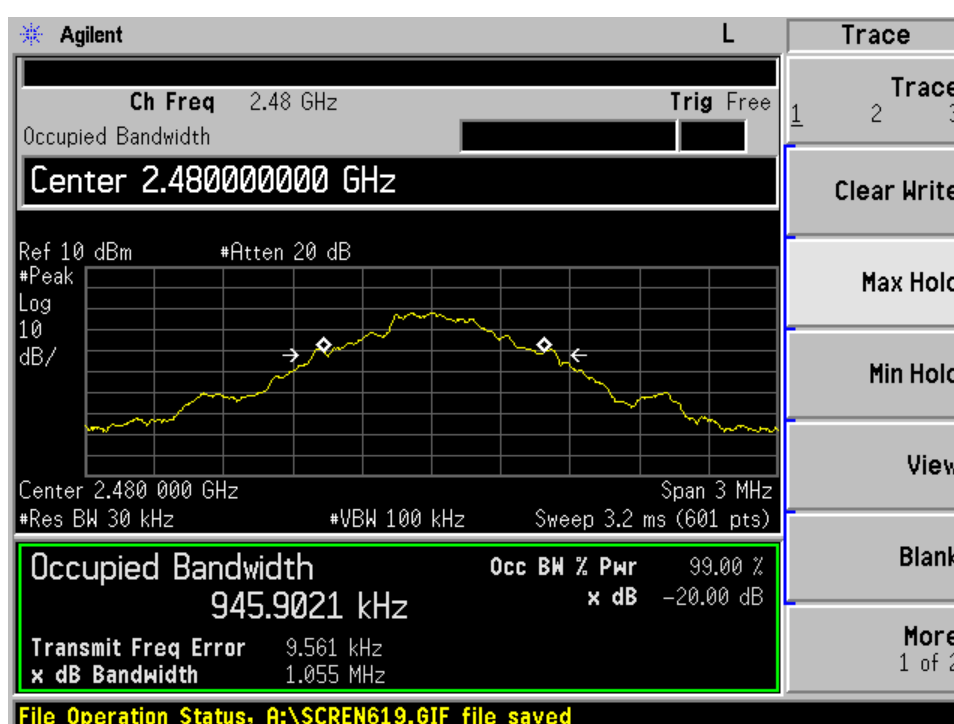
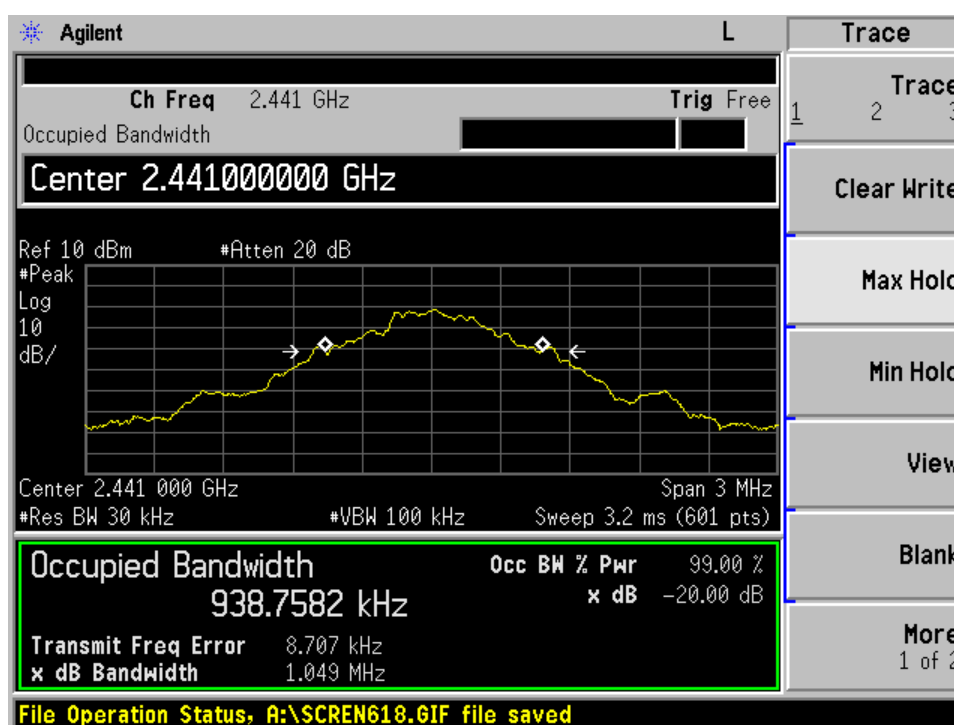
20 dB bandwidth

Bluetooth Mode GFSK Modulation test result

Frequency MHz	Bandwidth kHz	Result
2402	1048	Pass
2441	1049	Pass
2480	1055	Pass



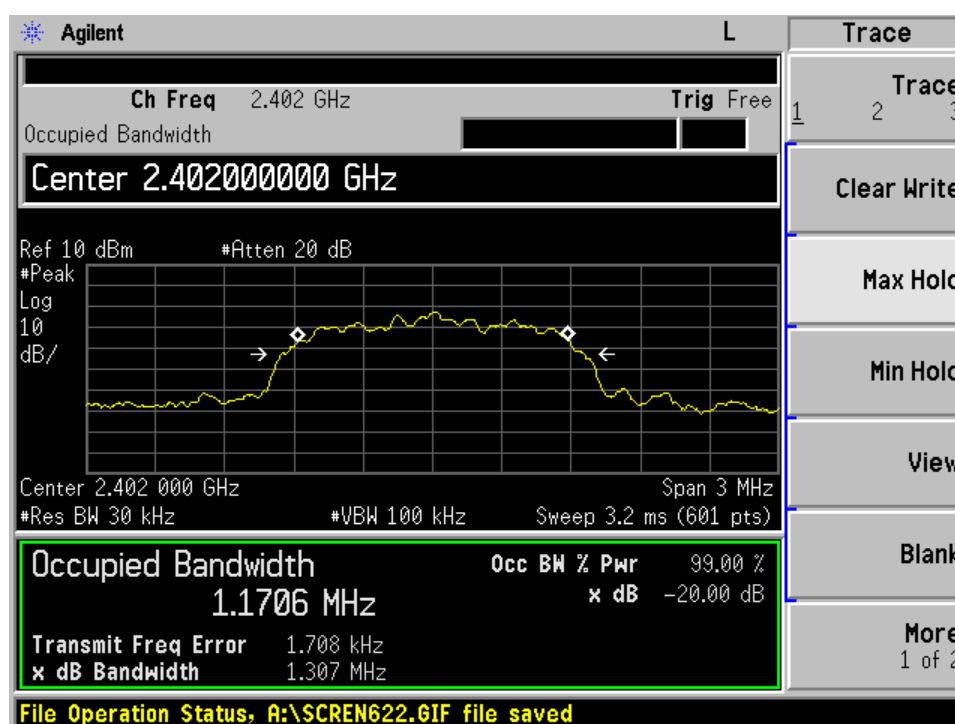
20 dB bandwidth



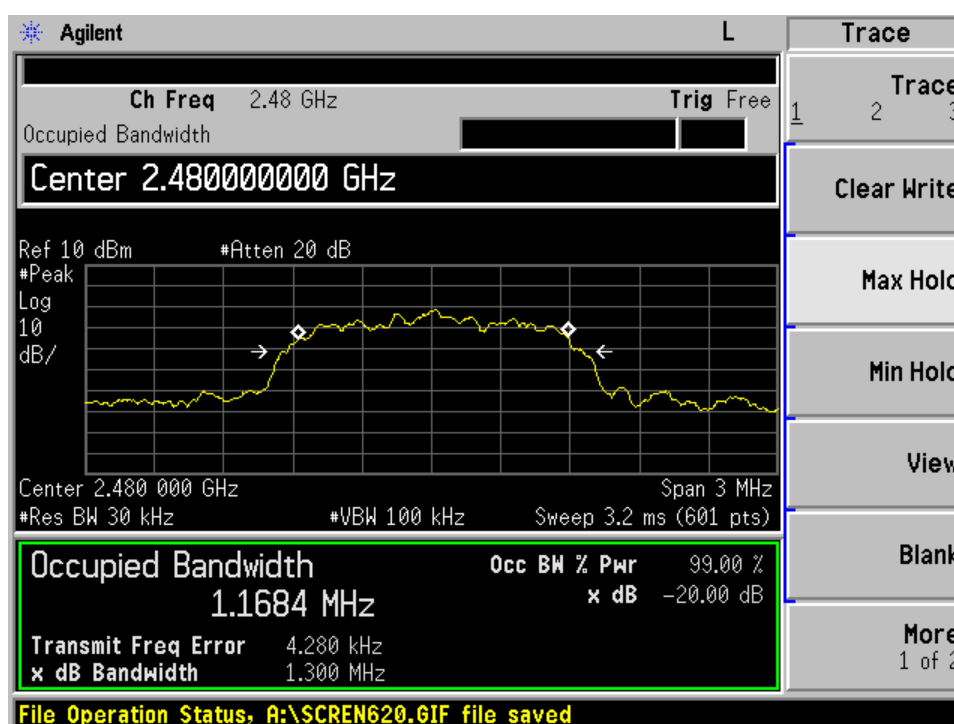
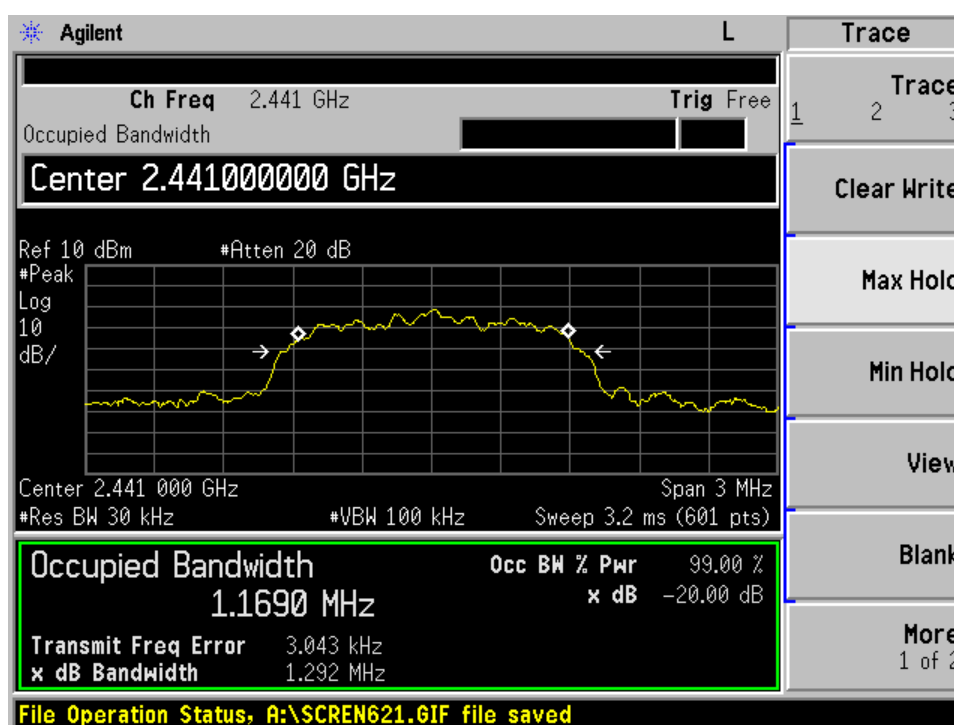
20 dB bandwidth

Bluetooth Mode 8DPSK Modulation test result

Frequency MHz	Bandwidth kHz	Result
2402	1307	Pass
2441	1292	Pass
2480	1300	Pass



20 dB bandwidth



Test Equipment

20 dB bandwidth Test

DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.	CAL.DUE.DATE
Spectrum Analyzer	Agilent	E74505A	MY45111421	Nov. 10, 2011

7.7 Carrier Frequency Separation

Test Method

1. Connect EUT antenna terminal to the spectrum analyzer with a low loss cable.
Equipment mode: Spectrum analyzer
RBW: 100KHz; VBW: 300KHz; SPAN:3MHz
2. By using the Max-Hold function record the separation of two adjacent channels.
3. Measure the frequency difference of these two adjacent channels by spectrum analyzer Marker function.
4. Repeat above procedures until all frequencies measured were complete.

Limit

Limit kHz
≥ 25 or 2/3 of the 20 dB bandwidth which is greater

GFSK Modulation Limit

Frequency MHz	2/3 of 20 dB Bandwidth kHz
2402	627
2441	629
2480	627

8DPSK Modulation Limit

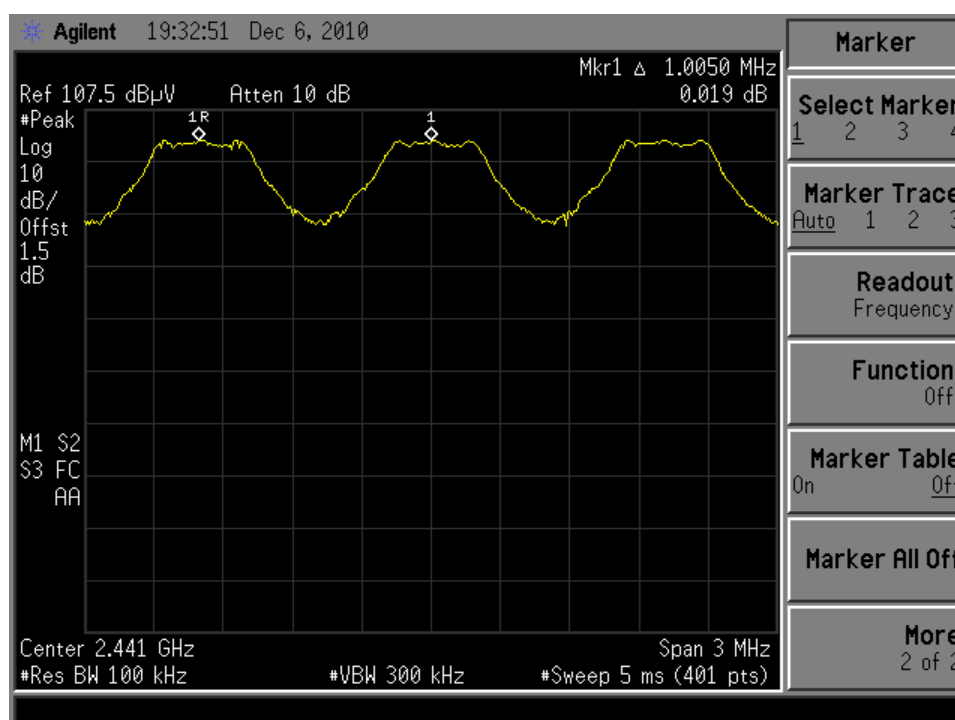
Frequency MHz	2/3 of 20 dB Bandwidth kHz
2402	772
2441	772
2480	772

Carrier Frequency Separation

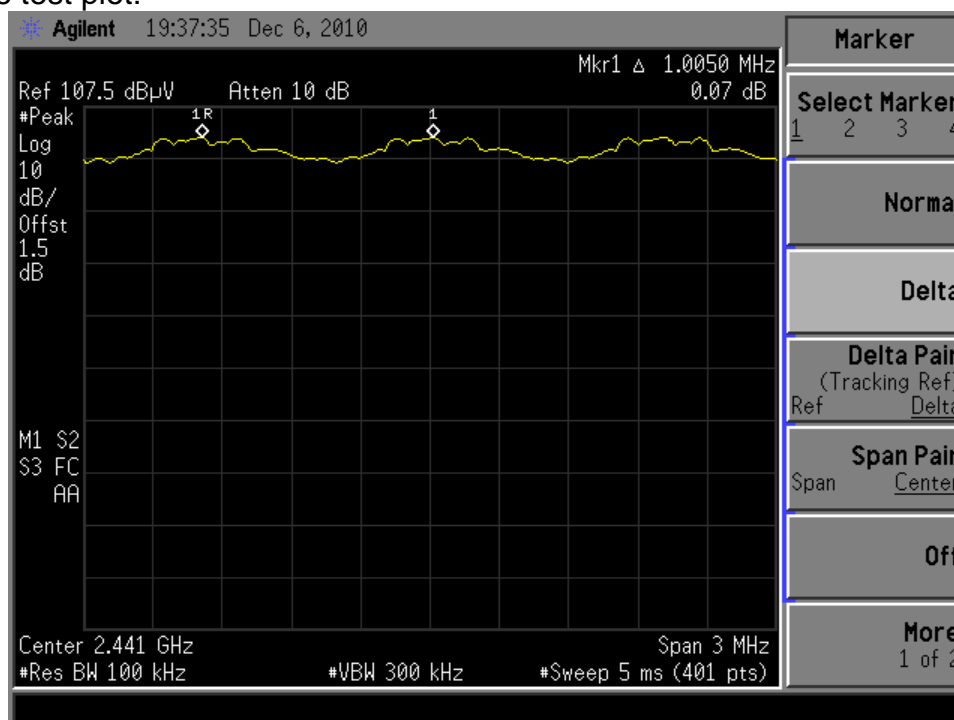
Test result

Modulations	Carrier Frequency Separation kHz	Result
GFSK	1005	Pass
8DPSK	1005	Pass

GFSK mode test plot:



8DPSK mode test plot:



Test Equipment

Carrier Frequency Separation Test

DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.	CAL.DUE.DATE
Spectrum Analyzer	Agilent	E74505A	MY45111421	Nov. 10, 2011

7.8 Number of hopping frequencies

Test Method

1. Connect EUT antenna terminal to the spectrum analyzer with a low loss cable.
Equipment mode: Spectrum analyzer
RBW: 300KHz; VBW: 1MHz
2. Set the spectrum analyzer on Max-Hold Mode, and then keep the EUT in hopping mode. Record all the signals from each channel until each one has been recorded.
3. Repeat above procedures until all frequencies measured were complete.

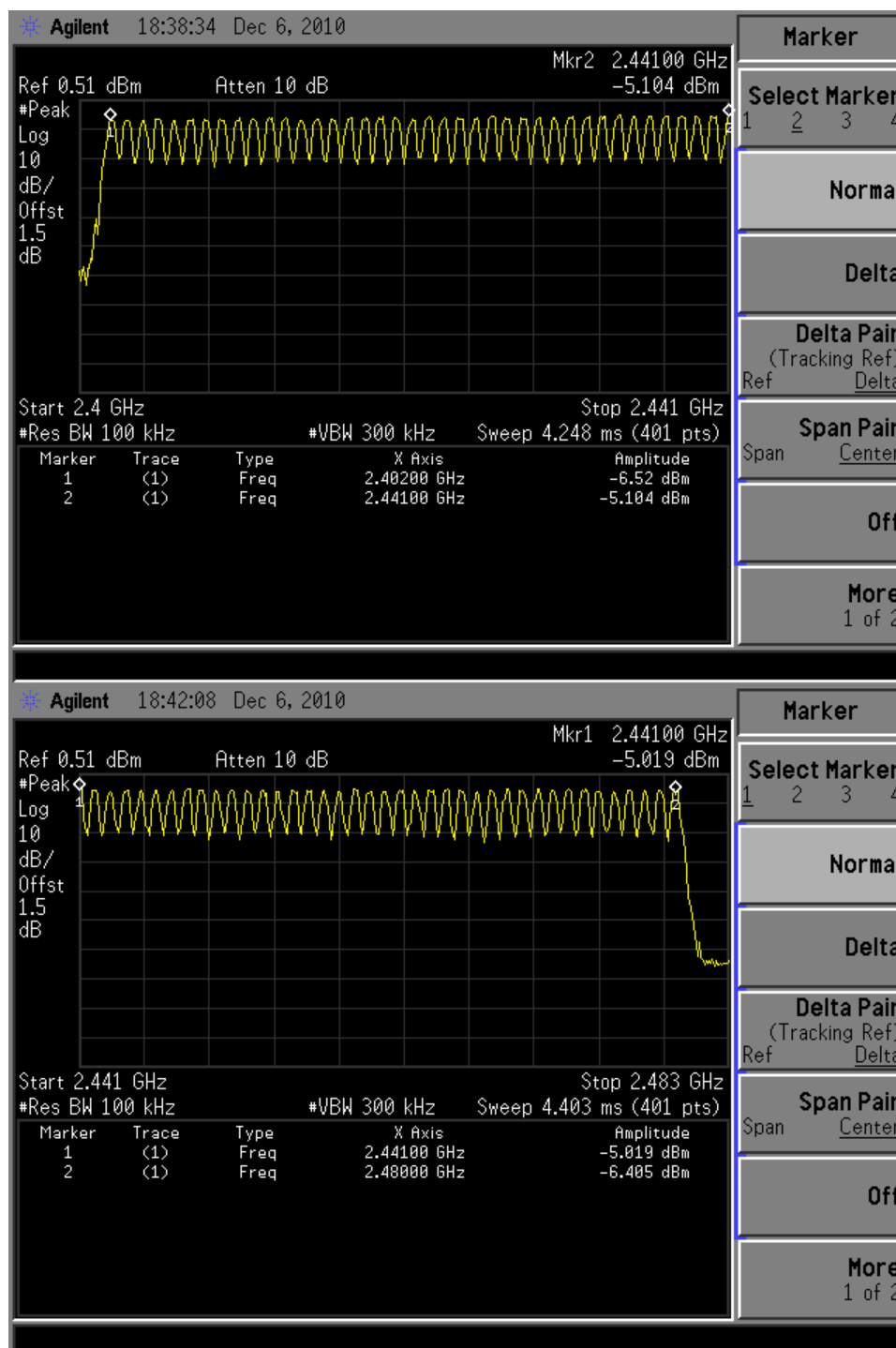
Limit

Limit number
≥ 15

Number of hopping frequencies

Bluetooth Mode GFSK Modulation test result:

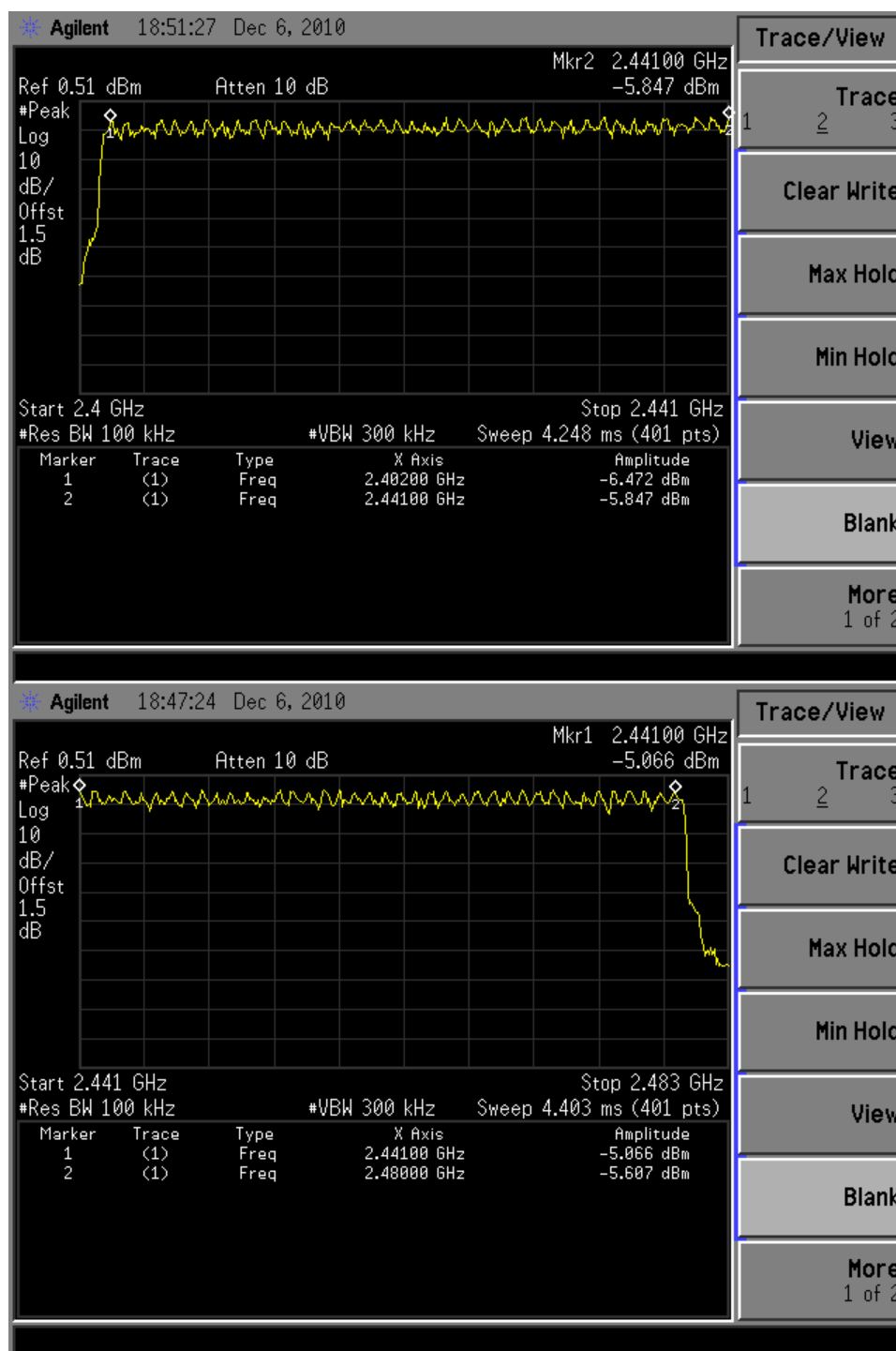
Number of hopping frequencies	Result
79	Pass



Number of hopping frequencies

Bluetooth Mode 8DPSK Modulation test result:

Number of hopping frequencies	Result
79	Pass



Test Equipment

Number of hopping frequencies Test

DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.	CAL.DUE.DATE
Spectrum Analyzer	Agilent	E74505A	MY45111421	Nov. 10, 2011

7.9 Dwell Time

Test Method

1. Connect EUT antenna terminal to the spectrum analyzer with a low loss cable.

Equipment mode: Spectrum analyzer

RBW: 1MHz; VBW: 1MHz; SPAN: Zero Span

2. Adjust the center frequency of spectrum analyzer on any frequency be measured.

3. Measure the Dwell Time by spectrum analyzer Marker function.

4. Repeat above procedures until all frequencies measured were complete.

Limit

The average time of occupancy on any frequency shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed.

Dwell Time

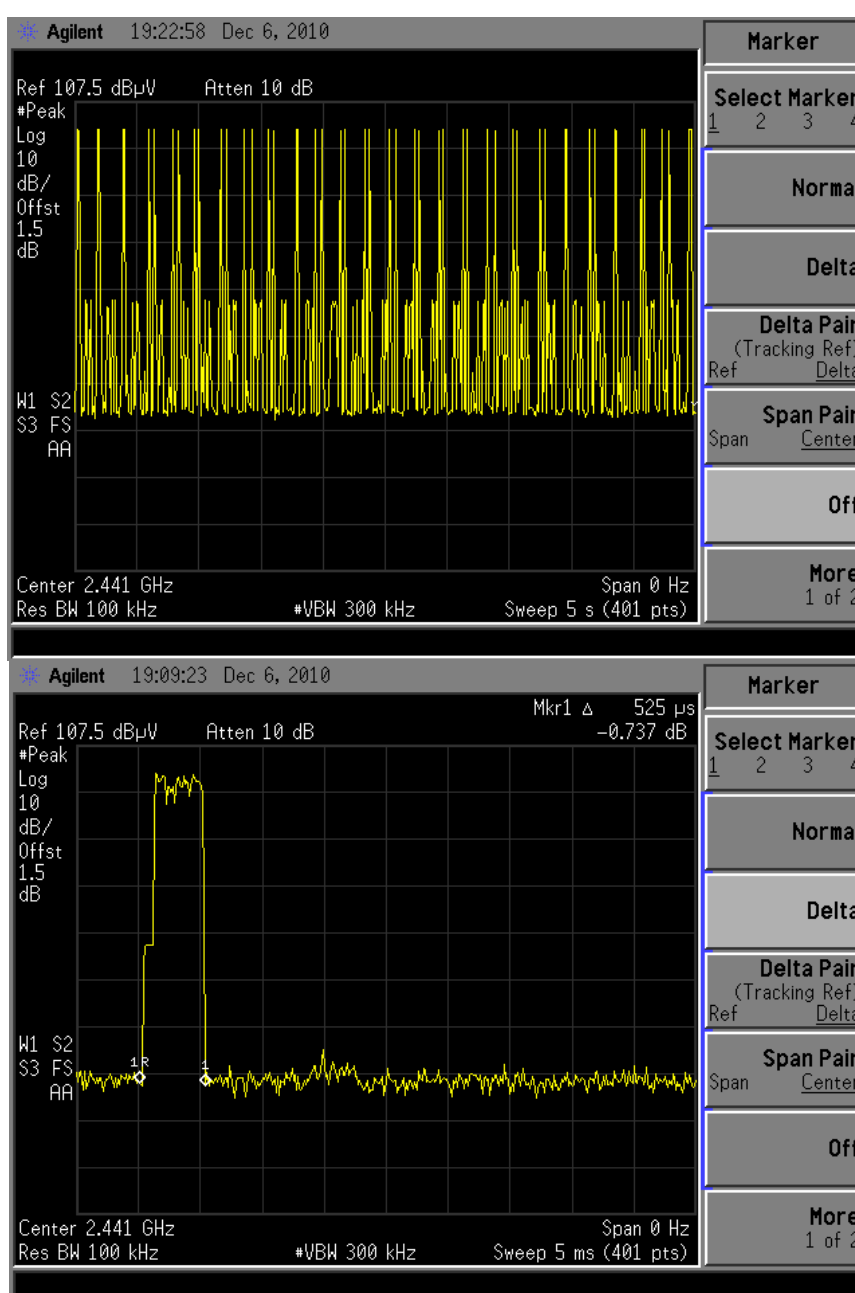
Dwell time

The maximum dwell time shall be 0,4 s.

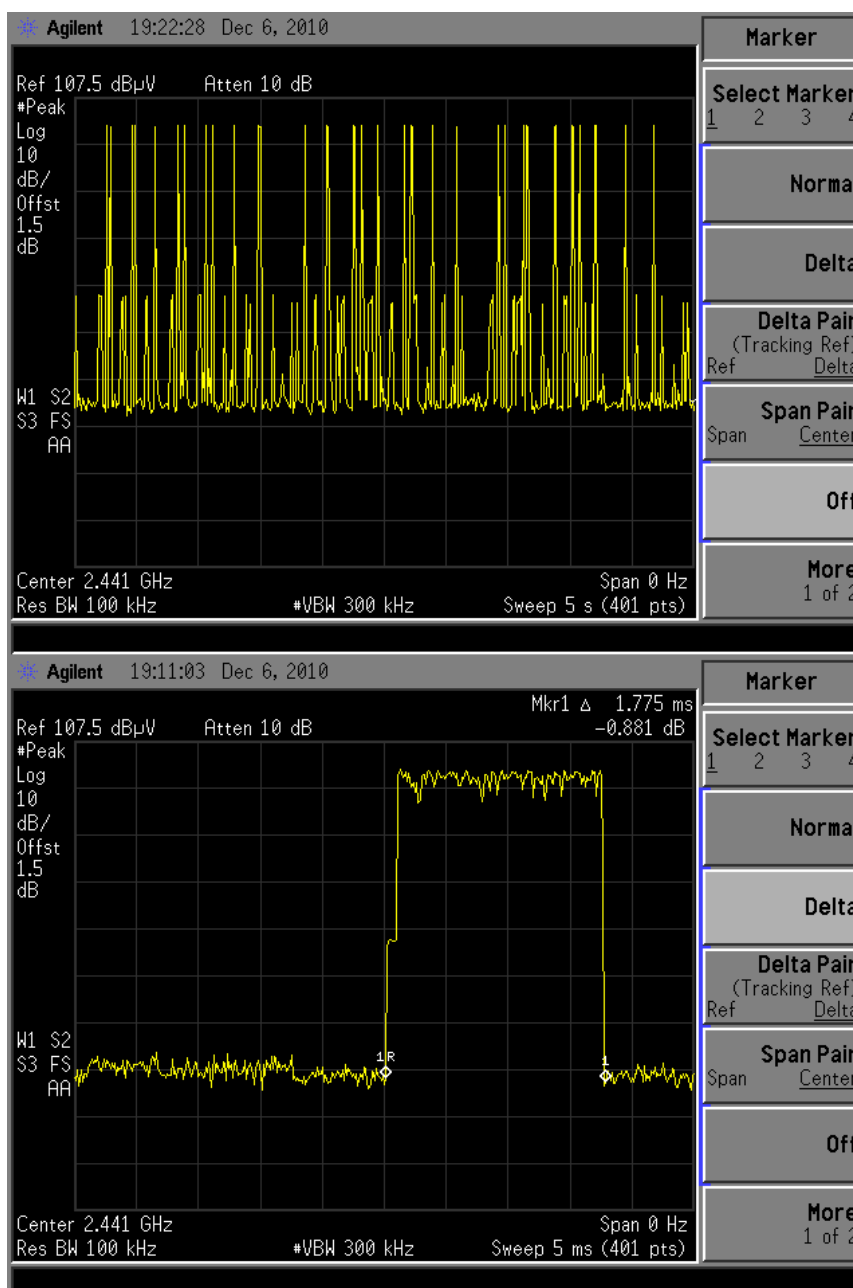
Bluetooth Mode GFSK Modulation:

Test Result

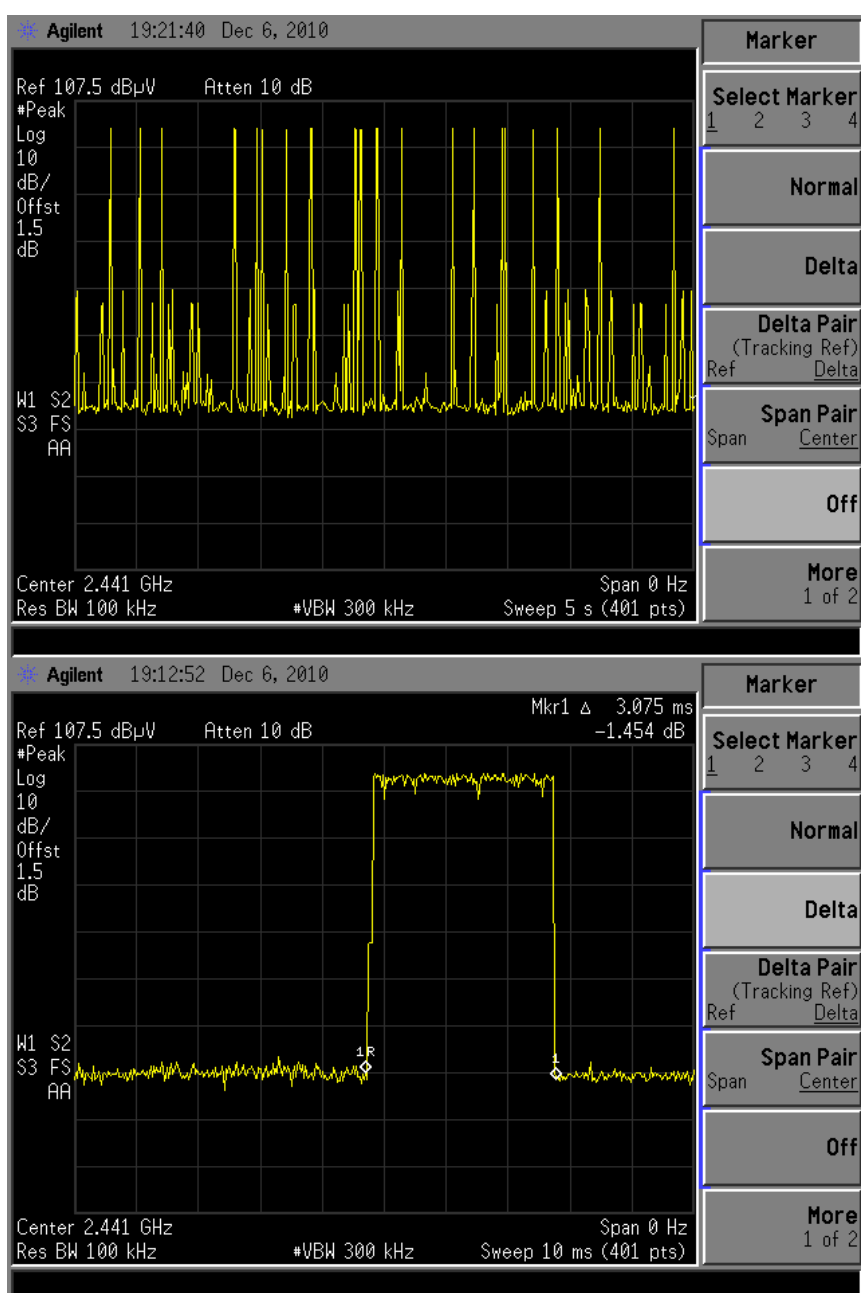
Mode	Reading (μs)	Test Result (ms)	Limit (ms)	Result
DH1	525	155.95	< 400	Pass
DH3	1775	314.10	< 400	Pass
DH5	3075	362.24	< 400	Pass



DH1



DH3



DH5

Note:

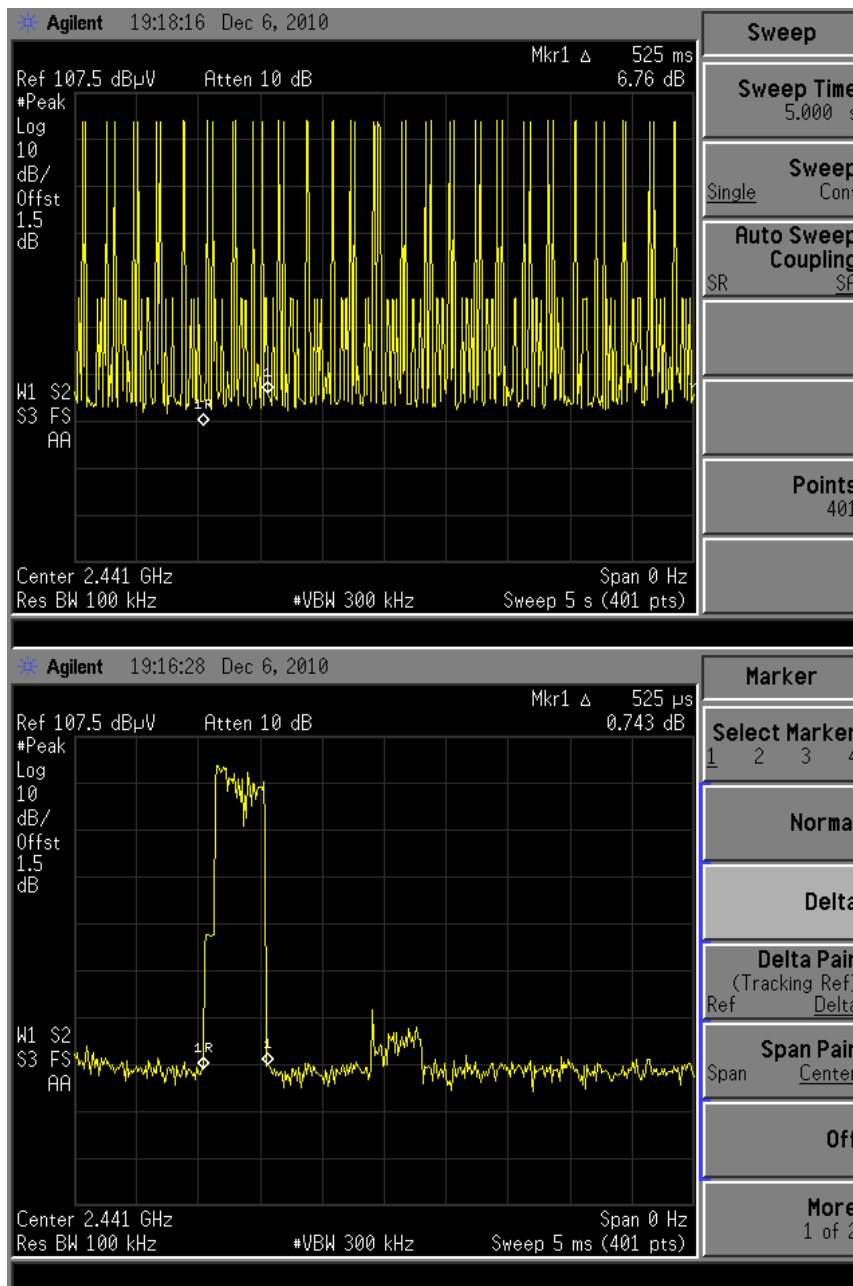
 $A \text{ period time} = 79 \times 0.4(s) = 31.6(s)$

DH1	time slot= 47(times)/5(s) * 525 (μs) * 31.6(s)= 155.95 (ms)
DH3	time slot= 28(times)/5(s) * 1775 (μs) * 31.6(s)= 314.10 (ms)
DH5	time slot= 19(times)/5(s) * 3075 (μs) * 31.6(s)= 362.24 (ms)

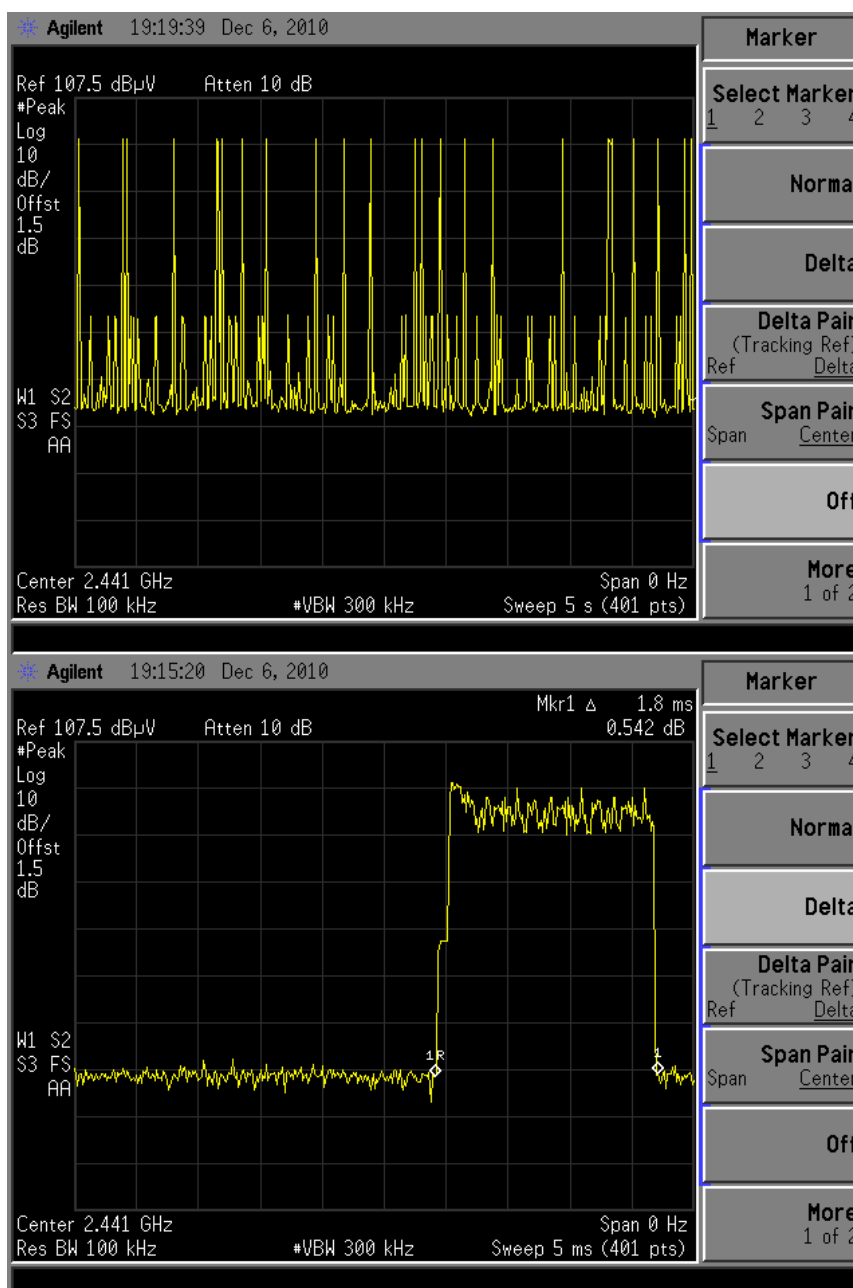
Bluetooth Mode 8DPSK Modulation:

Test Result

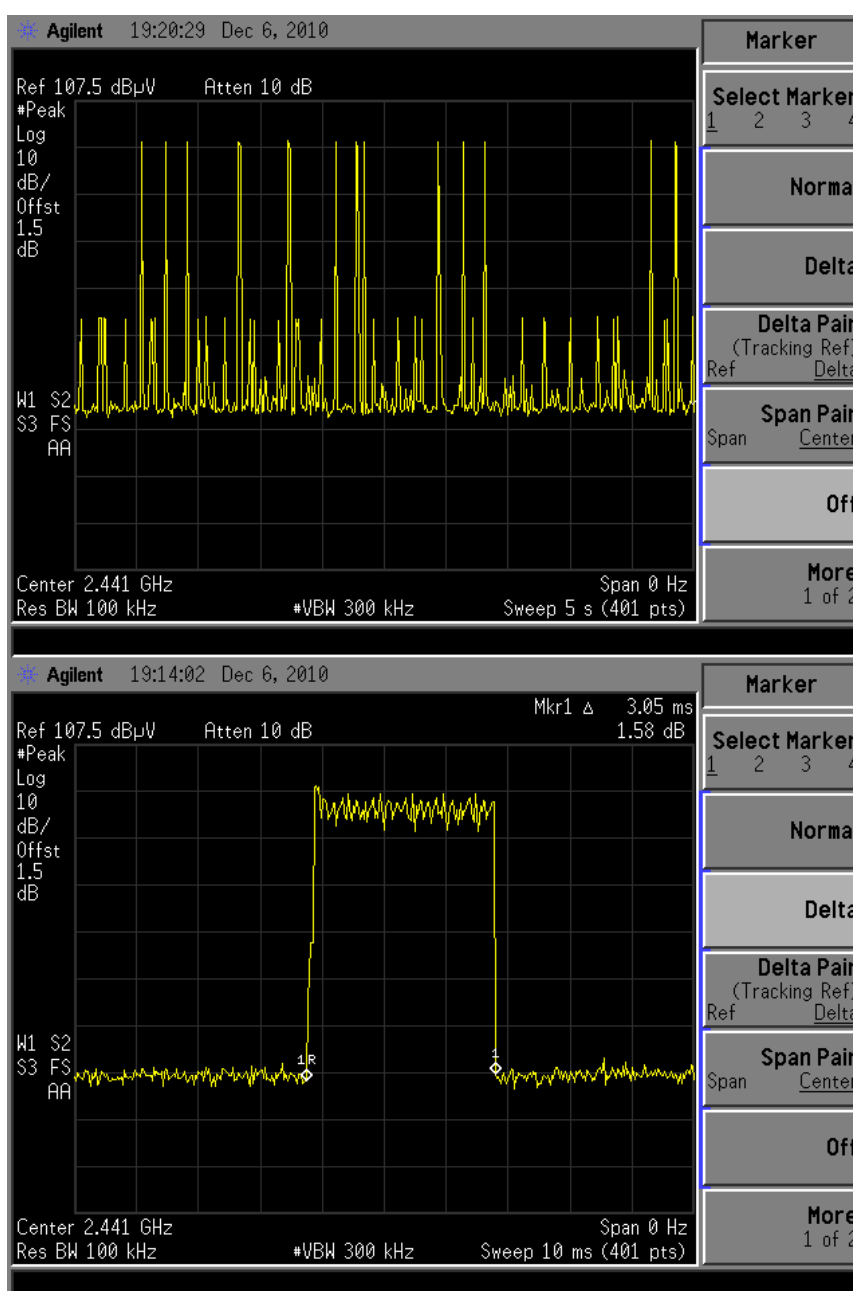
Mode	Reading (μs)	Test Result (ms)	Limit (ms)	Result
DH1	525	149.31	< 400	Pass
DH3	1800	216.64	< 400	Pass
DH5	3050	250.58	< 400	Pass



DH1



DH3



DH5

Note:

A period time=79x0.4(s)=31.6(s)

DH1	time slot= 45(times)/5(s) *525 (μs) *31.6(s)= 149.31 (ms)
DH3	time slot= 23(times)/5(s) *1800 (μs) *31.6(s)= 216.64 (ms)
DH5	time slot= 13(times)/5(s) *3050 (μs) *31.6(s)= 250.58 (ms)

Test Equipment

Dwell Time Test

DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.	CAL.DUE.DATE
Spectrum Analyzer	Agilent	E74505A	MY45111421	Nov. 10, 2011

8 System Measurement Uncertainty

For a 95% confidence level, the measurement expanded uncertainties for defined systems, in accordance with the recommendations of ISO 17025 were:

System Measurement Uncertainty

Items		Extended Uncertainty
RE	Field strength (dB μ V/m)	U=4.32dB (30MHz-25GHz)
CE	Disturbance Voltage (dB μ V)	U=2.40dB(150KHz-30MHz)